

High-Z detectors for Photon Science

Abdul K Rumaiz, NSLS II, Brookhaven National Laboratory

IFDEPS workshop
April 8th 2021

Collaborations

Brookhaven National Laboratory: D.P. Siddons, A.J. Kuczewski, I. Harding, J. Mead, S. Lamarra, A. Bolotnikov, D. Pinelli, R. Angona, G. Giacomini, G. Deptuch, G. Carini

Cornell University: S.M. Gruner, J. Thom-Levy, M. Tate, K. Shanks

Stony Brook University: A. Goldan, W. Zhao, A. Mukherjee, T. Ho

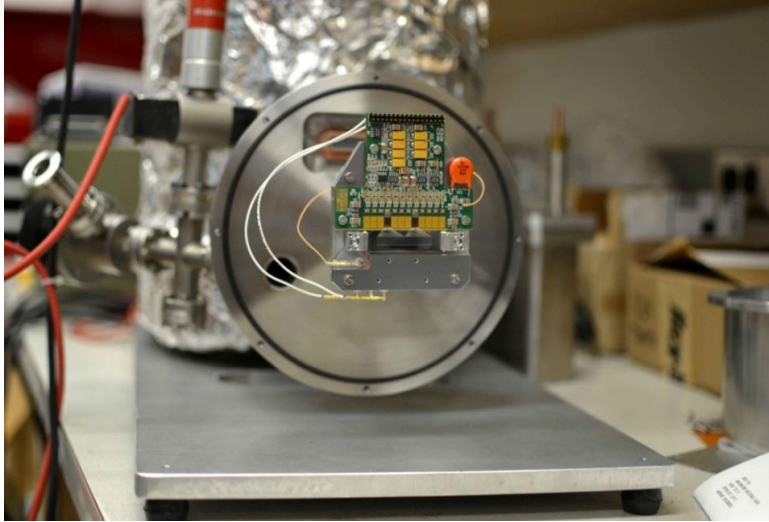
AGH Krakow: P. Maj, P. Grybos, R. Szczygiel

Argonne National Laboratory: N. Miceli

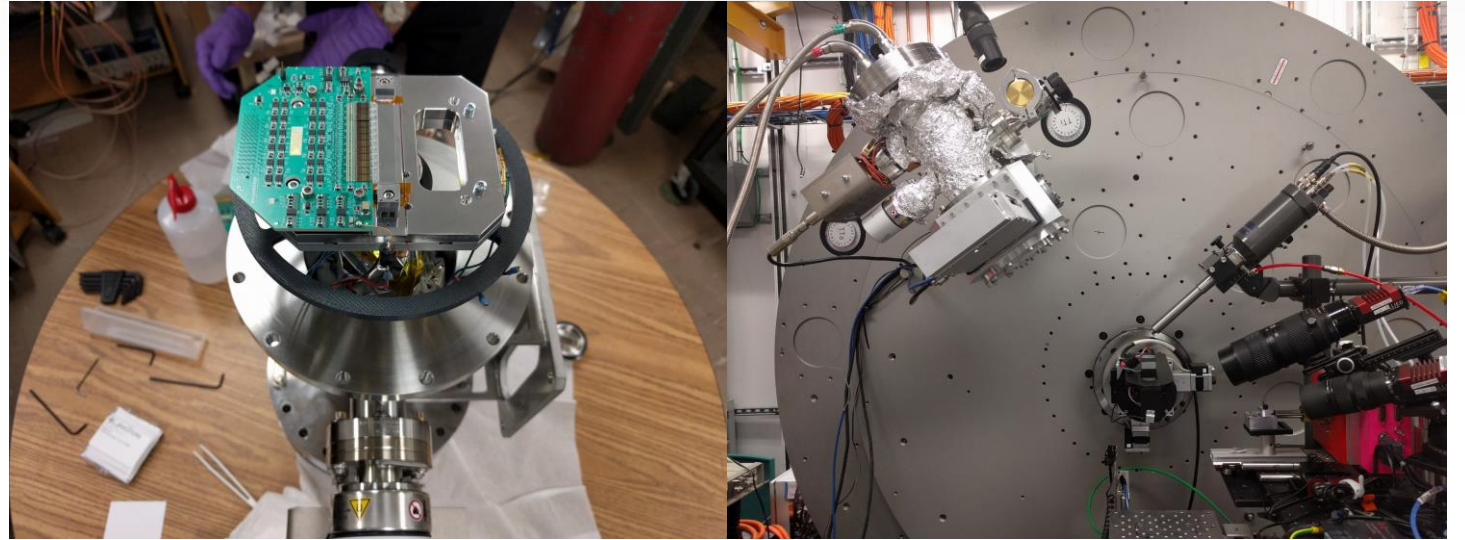
FZ-Julich: T. Krings

Multi-element Germanium detector

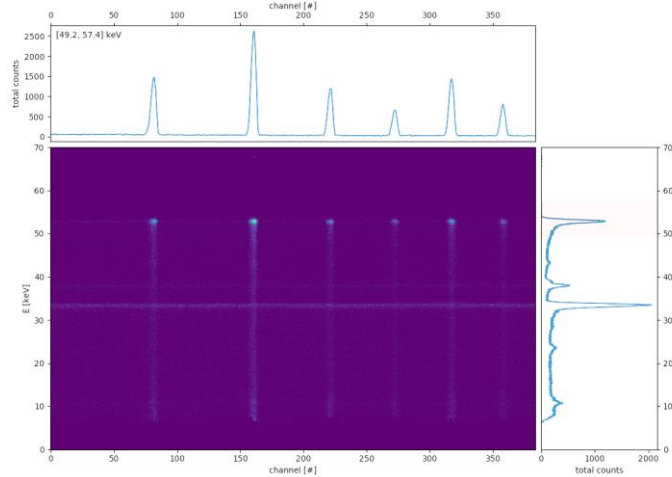
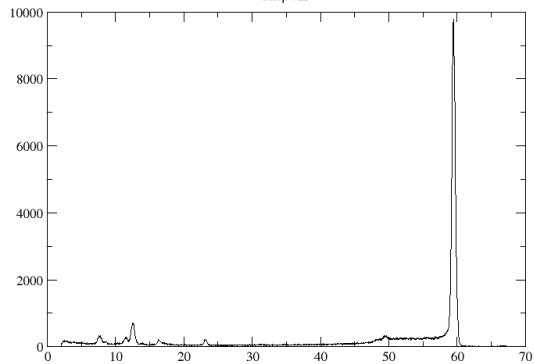
64- strip at XPD beamline at NSLS II



384- strip at XPD beamline at NSLS II



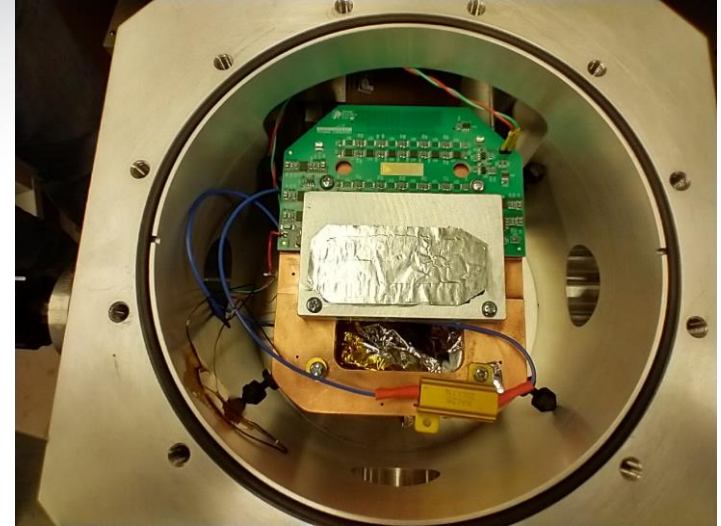
Am241 energy spectrum
Strip #29



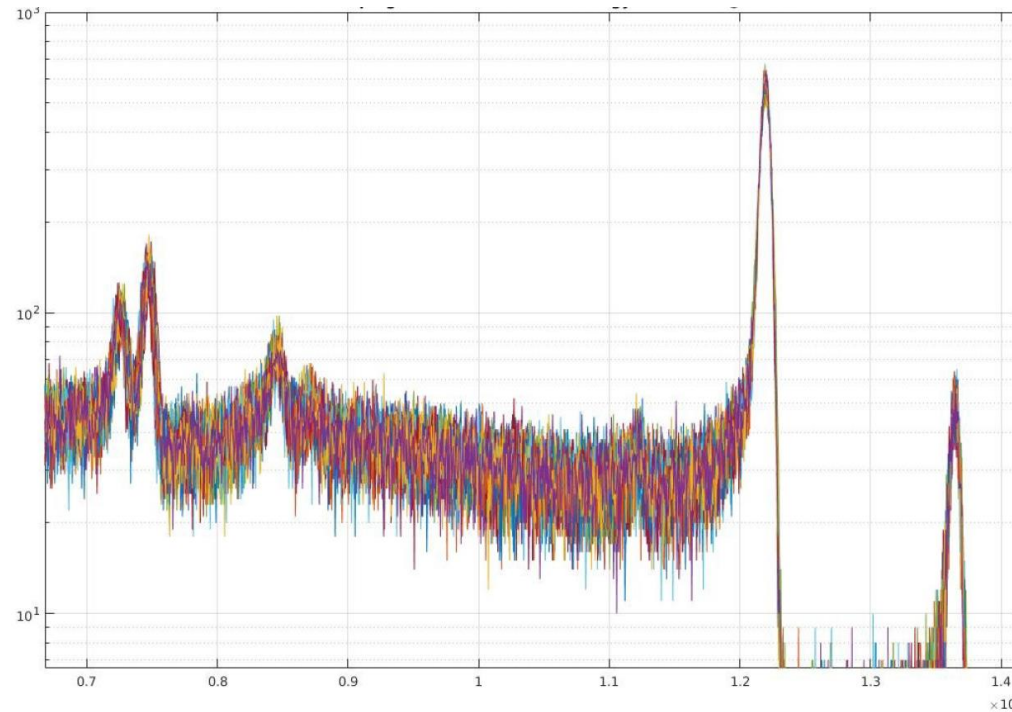
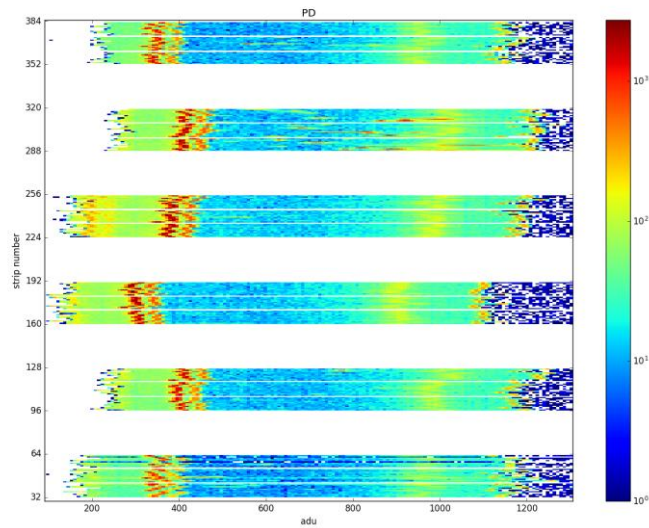
First data on LaB_6 at XPD

Multi-element Germanium detector

- 192-strip detector for HEX beamline at NSLS II
- Up to 200 KeV with 1% energy resolution
- New chip HE-MARS with lower gain



Initial test with Am source with Mo foil



Co-57 source

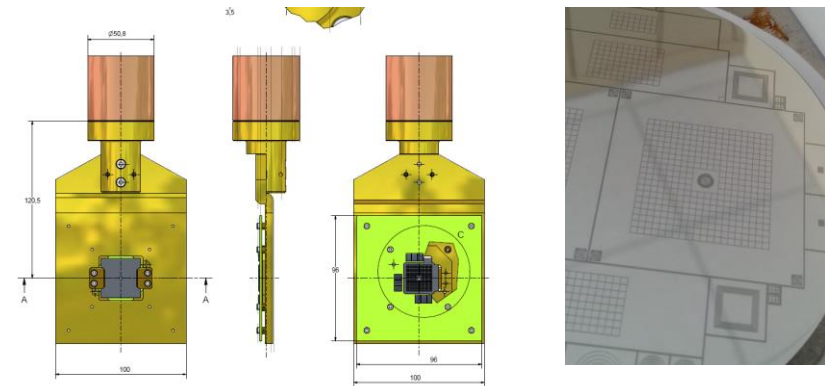
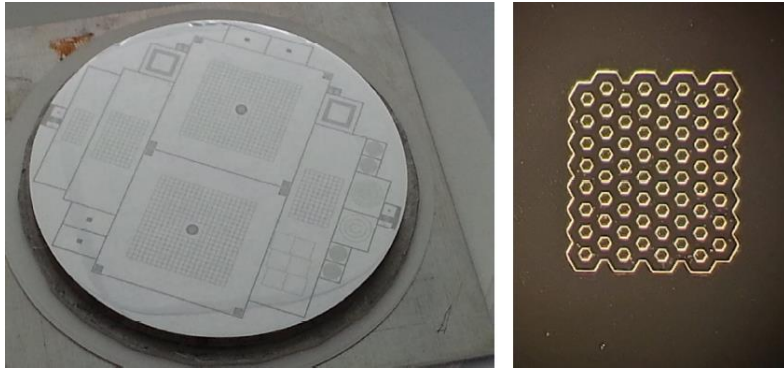
Resolution \sim 850 eV

GALAHAD: Germanium Array for Low And High energy Area Detector

- Develop Ge based spectroscopic imaging detector
- Cold ASIC bump bonded to Ge (Tapeout 2021)

384-pin diode array: This will be used to fabricate a 384 multi-element Germanium fluorescence detector (GAIA)

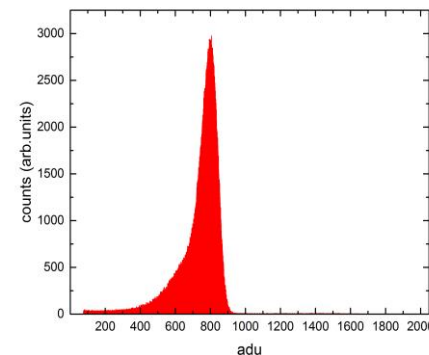
Fully processed Ge sensor



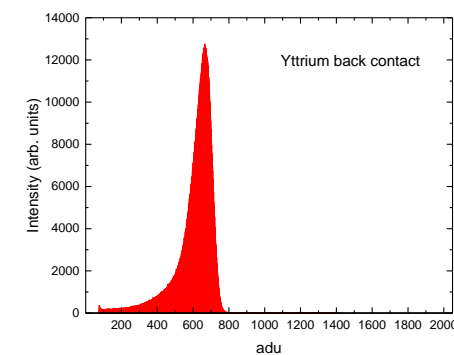
Alternate n+ contact in Ge

- Lithium diffusion is quite thick
- Ok for uniform back contact but cannot be masked
- Thick dead layer in the order of 100s of microns, undesirable for certain application

Phosphor doped and laser annealed



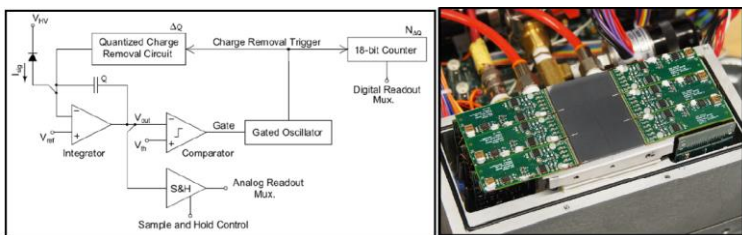
Yttrium n+ contact



Evaluation of high-Z detector materials for X-ray Science

- The project was to use some well established high-Z sensor (Ge, CZT and perovskites) in a hybrid pixel array detector Prototypes
- Collaboration between BNL, Cornell, SLAC, ANL, and Northwestern U
- Bonding the three candidates to three ASICs used in synchrotron facilities and FEL: MM-Pad, e-Pix and UFXC
- Collaborative tests involving members of the team: LCLS-II, APS (Northwestern U), NSLS-II and CHESS

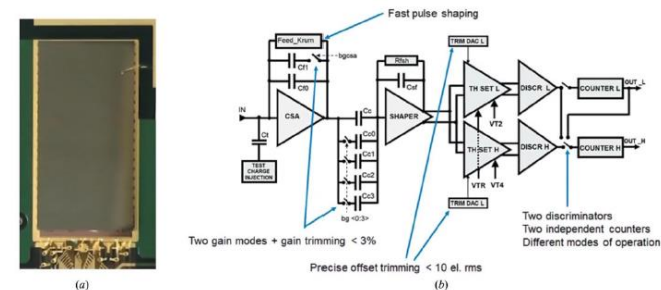
MM-Pad (Cornell)



e-Pix (SLAC)

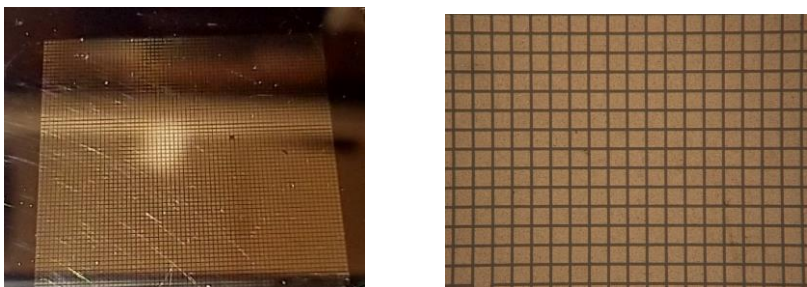


UFXC (Krakow)

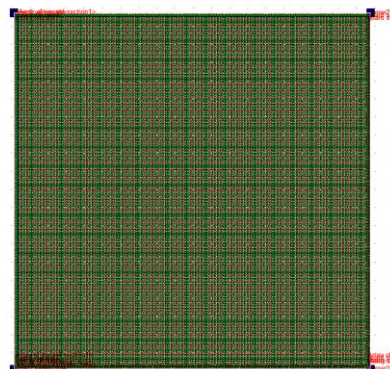


Pixelated high-flux CZT (BNL)

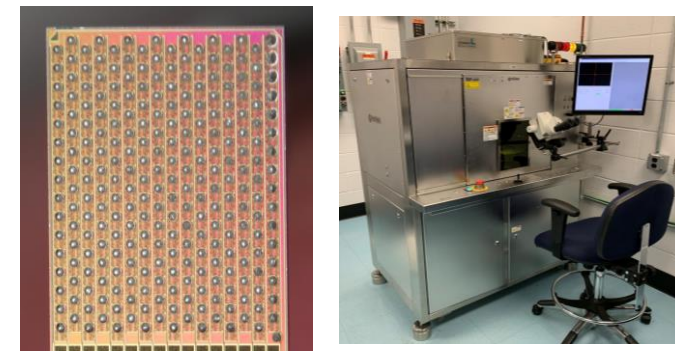
High flux CZT from Redlen. Pixelation (130 um) done at BNL



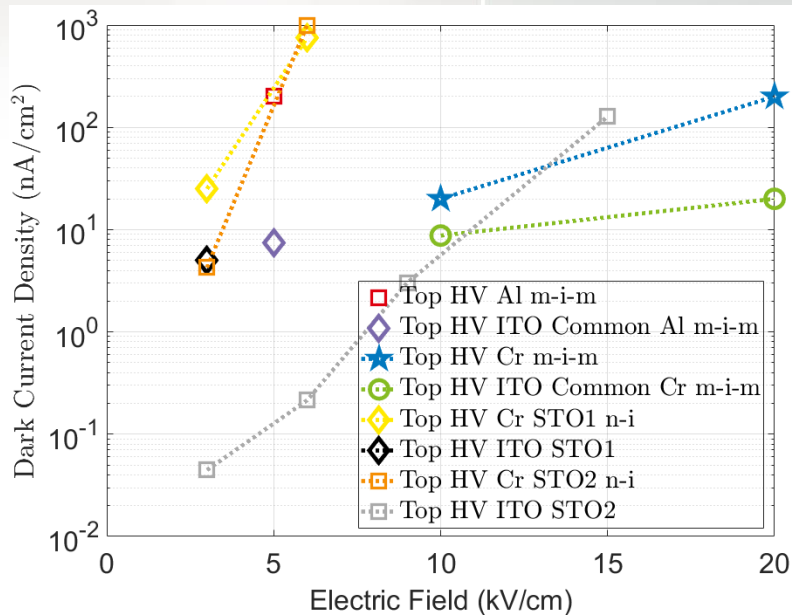
Ge sensor layout for MM-pad (BNL)
128X128 pixels



Bonding (BNL and SLAC)

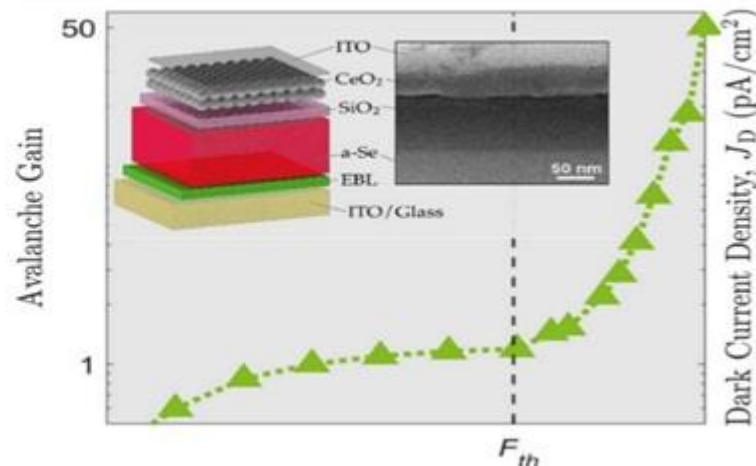
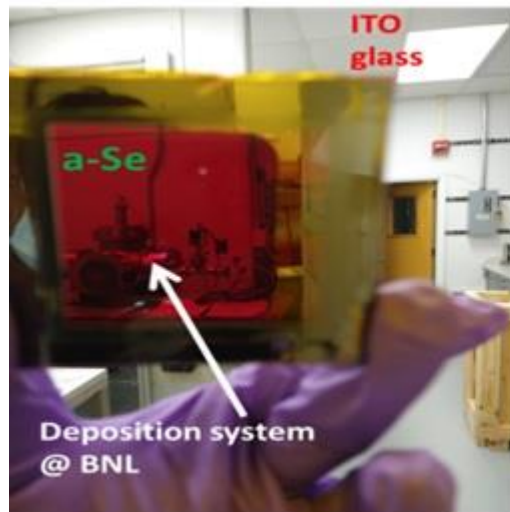


Amorphous Selenium for Hard X-rays



- Amorphous selenium is used in Medical imaging.
- High spatial resolution (below 10 microns) can be achieved for hard X-rays.
- Direct deposition of the active layer on readout electronics.
- Size not limited by crystal quality issues. Can be evaporated over large area.

On going project with Stony Brook Medicine. We have developed deposition tools to grow thick Se in house. Work on developing robust hole blocking layer.

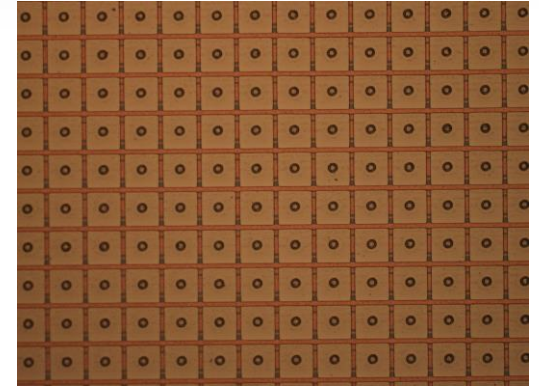
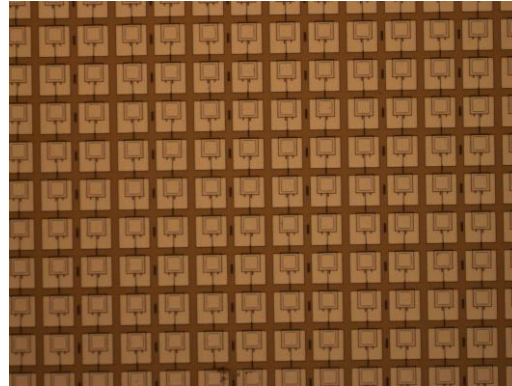
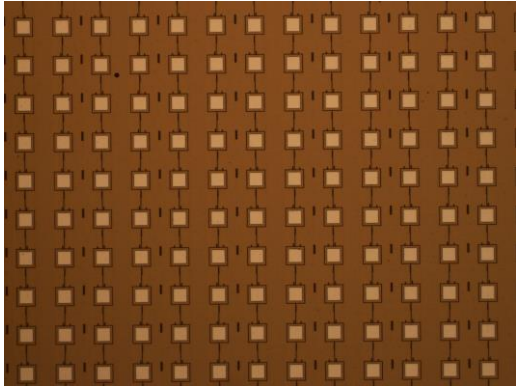


Amorphous Selenium for Hard X-rays

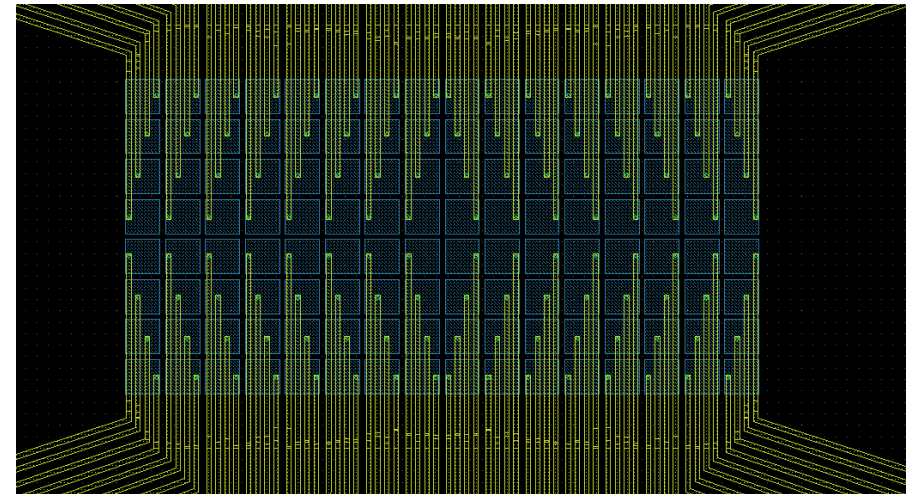
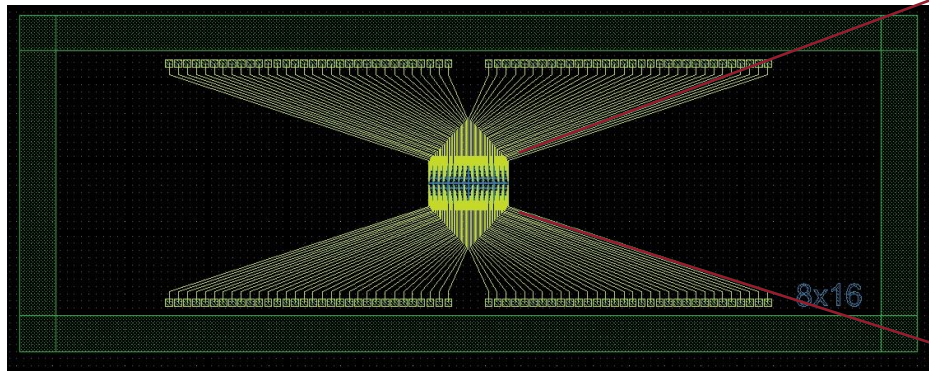
Direct deposition on CMOS chips

MM Pad: Top metal pad extension for improved fill factor

UFXC



Spectroscopy with MARS ASIC





Questions?